

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/669,149	09/23/2003	Erich Strasser	56/417	2988
757	7590 06/02/2005		EXAMINER	
BRINKS HOFER GILSON & LIONE			MONBLEAU, DAVIENNE N	
P.O. BOX 10395 CHICAGO, IL 60610			ART UNIT	PAPER NUMBER
•			2878	
			DATE MAILED: 04/02/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary		Application No.	Applicant(s)				
		10/669,149	STRASSER, ERICH (MW				
		Examiner	Art Unit				
		Davienne Monbleau	2878				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
THE - Exte after - If the - If NC - Failt Any	MAILING DATE OF THIS COMMUNICATION. Insions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. In period for reply specified above is less than thirty (30) days, a reply of period for reply is specified above, the maximum statutory period we use to reply within the set or extended period for reply will, by statute, reply received by the Office later than three months after the mailing led patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply within the statutory minimum of thirty (30 will apply and will expire SIX (6) MONTHS cause the application to become ABANI	be timely filed i) days will be considered timely. from the mailing date of this communication. DONED (35 U.S.C. & 133)				
Status							
1)⊠	Responsive to communication(s) filed on 23 Se	eptember 2003.					
_	This action is FINAL . 2b)⊠ This action is non-final.						
3)□	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.						
Disposit	ion of Claims						
5)□ 6)⊠ 7)□	Claim(s) 1-17 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw Claim(s) is/are allowed. Claim(s) 1-17 is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or	vn from consideration.					
Applicat	ion Papers						
10)⊠	The specification is objected to by the Examine The drawing(s) filed on <u>23 September 2003</u> is/a Applicant may not request that any objection to the Replacement drawing sheet(s) including the correction The oath or declaration is objected to by the Ex	are: a)⊠ accepted or b)□ old drawing(s) be held in abeyance. ion is required if the drawing(s) i	See 37 CFR 1.85(a). s objected to. See 37 CFR 1.121(d).				
Priority (under 35 U.S.C. § 119						
12)⊠ a)l	Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the priorical application from the International Bureau See the attached detailed Office action for a list of	s have been received. s have been received in Appli ity documents have been rec ı (PCT Rule 17.2(a)).	ication No reived in this National Stage				
Attachmen							
	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948)	4) Interview Sumr					
3) 🔯 Inforr	mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) r No(s)/Mail Date 11/10/03		ail Date nal Patent Application (PTO-152)				

Application/Control Number: 10/669,149

Art Unit: 2878

DETAILED ACTION

Information Disclosure Statement

The IDS filed on 11/10/03 has been acknowledged and a signed copy of the PTO-1449 is attached herein.

Specification

The abstract of the disclosure is objected to because it is not written in proper grammatical sentences. Correction is required. See MPEP § 608.01(b).

Applicant is reminded of the proper language and format for an abstract of the disclosure.

The abstract should be in narrative form and generally limited to a single paragraph on a separate sheet within the range of 50 to 150 words. It is important that the abstract not exceed 150 words in length since the space provided for the abstract on the computer tape used by the printer is limited. The form and legal phraseology often used in patent claims, such as "means" and "said," should be avoided. The abstract should describe the disclosure sufficiently to assist readers in deciding whether there is a need for consulting the full patent text for details.

The language should be clear and concise and should not repeat information given in the title. It should avoid using phrases which can be implied, such as, "The disclosure concerns," "The disclosure defined by this invention," "The disclosure describes," etc.

Claim Rejections - 35 USC § 112

Claims 1-17 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Regarding Claim 1, the phrase "an arrangement of detector elements ... for generating a plurality of periodic scanning signals" is unclear. Detectors are known in the art for receiving signals, not emitting signals. Thus, the function of these detectors is indefinite.

Art Unit: 2878

Regarding Claim 12, the phrase "scanning ... by a detector arrangement" is unclear.

Detectors are known in the art for receiving signals, not emitting signals. Thus, the function of these detectors is indefinite.

Regarding Claim 13, the phrase "wherein said scanning results ... measurement range" is an incomplete phrase and it is not clear what is being done.

Claims 2-11 and 14-17 are rejected to as being based on indefinite base claims.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1, 8, and 10-12, to the extent taught and understood, are rejected under 35 U.S.C. 102(e) as being anticipated by Mayer et al. (U.S. 6,472,658).

The applied reference has a common assignee with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 102(e) might be overcome either by a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not the invention "by another," or by an appropriate showing under 37 CFR 1.131.

Regarding Claim 1, Mayer discloses in Figures 1 and 6 a position measuring instrument comprising a periodic incremental graduation (2) comprising a plurality of graduation periods

within one measurement range, a reference marking (R) disposed within said measurement range and integrated with said incremental graduation (2), an arrangement of detector elements over at least a length of said measurement range for generating a plurality of periodic scanning signals (column 5 lines 5-20) of which at least one is modified locally by said reference marking (R), and an evaluation device (5, 6) that receives said scanning signals and detects at least one scanning signal, modified by said reference marking, from said plurality of scanning signals and determines an absolute position of said reference marking within said length of said measurement range as a function of said detected at least one scanning signal (column 7 lines 61-65).

Regarding Claim 12, *Mayer* discloses in Figures 1 and 6 a method for position measurement comprising scanning (column 5 lines 5-20) a plurality of graduation periods of one incremental graduation (2) by a detector arrangement extending over a length of one measurement range, a reference marking (R) being integrated with one of said graduation periods, and generating a plurality of periodic scanning signals, of which at least one is locally modified by said reference marking (R), detecting (5, 6) said at least one scanning signal, modified by said reference marking (R), from among said plurality of periodic scanning signals, and determining an absolute position of said reference marking within said length of said measurement range as a function of said scanning signal detected (column 7 lines 61-65).

Regarding Claim 8, Mayer discloses in Figure 6, that said reference marking (R) is a variation of an interstice in a series of equally spaced markings which forms said incremental graduation (2).

Application/Control Number: 10/669,149

Art Unit: 2878

Regarding Claim 10, *Mayer* discloses in Figure 1 that parallel to and next to said incremental graduation (2), an absolute code (1) for absolute position measurement is disposed at measurement increments in accordance with said length of one measurement range.

Regarding Claim 11, *Mayer* discloses that said absolute code (1) is a single-track sequential code with successive code elements.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 2-7, 9, and 13-17, to the extent taught and understood, are rejected under 35 U.S.C. 103(a) as being obvious over Mayer in view of Keong (U.S. 2005/0006571).

The applied reference has a common assignee with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art only under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 103(a) might be overcome by: (1) a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not an invention "by another"; (2) a showing of a date of invention for the claimed subject matter of the application which corresponds to subject matter disclosed but not claimed in the reference, prior to the effective U.S. filing date of the reference under 37 CFR 1.131; or (3) an oath or declaration under 37 CFR 1.130 stating that the application and reference are currently owned by the same party and that the inventor named in

the application is the prior inventor under 35 U.S.C. 104, together with a terminal disclaimer in accordance with 37 CFR 1.321(c). This rejection might also be overcome by showing that the reference is disqualified under 35 U.S.C. 103(c) as prior art in a rejection under 35 U.S.C. 103(a). See MPEP § 706.02(l)(1) and § 706.02(l)(2).

Regarding Claim 2, Mayer teaches in Figures 1 and 6 that within said measurement range, N graduation periods are disposed, where N>1 and is an integer. Mayer teaches using plurality of detectors, but does not teach that said arrangement of detector elements over said length of said measurement range forms N groups, and each of said N groups of detector elements extends over said length of one graduation period, and within each of said N groups, a plurality of detector elements are spaced apart from one another by a fraction of one graduation period, so that, within one of said N groups, a plurality of periodic scanning signals phase-offset from one another are generated. Keong teaches in Figure 9 a linear position encoder comprising an incremental graduation (150) with a measurement range and at least two groups of detectors, wherein each detector group extends over one graduation period and the detector elements within each detector group are spaced apart from one another by a fraction of one graduation period, so that, a plurality of periodic scanning signals phase-offset from one another are generated. Keong does not teach that that there are N detector groups. It would have been obvious, however, to one of ordinary skill in the art at the time of the invention to use a particular number of detector groups and detector elements within each detector group in Mayer, to improve the resolution and position detection accuracy of the device. (See *Keong* paragraph [0004]).

Regarding Claims 3-5 and 13-17, methods for determining the absolute position of an object by evaluating the detected phase signals from the encoder are well known and involve

standard data analysis techniques. This includes comparing the detected phase signals from the scanned beams and interpolating the absolute position from the detected signals.

Regarding Claim 6, *Mayer* teaches in Figure 6 that said reference marker (R) is integrated into the incremental graduation (2), which is a phase grating. Thus, there is going to be interference in periodicity at the reference marker (R) location within the incremental graduation. Using a particular size reference marker (R) within said incremental graduation (2) depends on the desired characteristics of the position encoder. Furthermore, methods for determining the absolute position of an object by evaluating detected phase signals from the encoder are well known and involve standard data analysis techniques and may include comparing the detected phase signals from the scanned beams.

Regarding Claim 7, methods for determining the absolute position of an object by evaluating the detected phase signals from the encoder are well known and involve standard data analysis techniques. This includes comparing the detected phase signals from the scanned beams and interpolating the absolute position from the detected signals.

Regarding Claim 9, *Mayer* teaches in Figure that said reference marker (R) has a few components but does not teach a second reference marker. It would have been obvious, however, to one of ordinary skill in the art at the time of the invention to use a second reference marker in *Mayer* to more accurately determine the absolute position of the device. (See *Keong* paragraph [0004] stating that the ultimate resolution is determined by the stripe pattern, which would include reference markers).

Application/Control Number: 10/669,149

Art Unit: 2878

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's

disclosure: these references teach various position encoders that comprises incremental

graduations, code tracks, and reference markers.

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Davienne Monbleau whose telephone number is 571-272-1945.

The examiner can normally be reached on Mon-Fri 9:00 am to 5:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Dave Porta can be reached on 571-272-2444. The fax phone number for the

organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent

Application Information Retrieval (PAIR) system. Status information for published applications

may be obtained from either Private PAIR or Public PAIR. Status information for unpublished

applications is available through Private PAIR only. For more information about the PAIR

system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR

system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Danienne Monbleaus

DAVID PORTA SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 2800

Page 8